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problem : Alexei A. Erchak

Art Unit : 2879

Serial No.:

: 10/724,015

Examiner: Glenn Zimmerman

Filed

: November 26, 2003

Title

: LIGHT EMITTING DIODES

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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office Action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 7/29/05

Sean P. Daley Reg. No. 40,978

Fish & Richardson P.C. 225 Franklin Street Boston, MA 02110

Telephone: (617) 542-5070 Facsimile: (617) 542-8906

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Bustitute Form PTO-1449 (Modified) nformation Disclosure Statement 0 1 2005 AU6 (Use several sheets if necessary)

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 16459-011001

Application No. 10/724,015

Applicant

Alexei A. Erchak

Filing Date

Group Art Unit

by Applicant

November 26, 2003 2879

U.S. Patent Documents							
Examiner Initial	, • ,		Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,126,231	June 30, 1992	Levy			
	AB	6,778,746	August 17, 2004	Charlton, et al.			
	AC	6,742,907	June 1, 2004	Funamoto, et al.			
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Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 16459-011001	Application No. 10/724,015	_
	closure Statement	Applicant Alexei A. Erchak		
		Filing Date November 26, 2003	Group Art Unit 2879	_

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AAA	6,778,746	August 17, 2004	Charlton, et al.			
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	ACC	6,307,218	October 23, 2001	Steigerwald et al.			
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AEE							
	AFF							
	AGG	.,						
	АНН							
	AII							

Other Documents (include Author, Title, Date, and Place of Publication)						
Examiner	Desig.					
Initial	ID	Document				
	AJJ					
	AKK					
	ALL					
	AMM					

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